**TOSHIBA** 3SK127

#### TOSHIBA FIELD EFFECT TRANSISTOR SILICON N CHANNEL DUAL GATE MOS TYPE

# 3 S K 1 2 7

TV TUNER, UHF RF AMPLIFIER APPLICATIONS TV TUNER, UHF MIXER APPLICATIONS

Superior Cross Modulation Performance.

Low Reverse Transfer Capacitance : C<sub>rss</sub>=0.03pF (Max.)

Low Noise Figure : NF = 3.2dB (Typ.)

### MAXIMUM RATINGS (Ta = 25°C)

CHARACTERISTIC	SYMBOL	RATING	UNIT
Drain-Source Voltage	$V_{\mathrm{DS}}$	15	V
Gate 1 - Source Voltage	V <sub>G1S</sub>	±8	V
Gate 2 - Source Voltage	$v_{G2S}$	±8	V
Drain Current	$I_{\mathbf{D}}$	30	mA
Drain Power Dissipation	$P_{\mathbf{D}}$	150	mW
Channel Temperature	$\mathrm{T_{ch}}$	125	°C
Storage Temperature Range	$T_{ m stg}$	-55~125	°C

## Unit in mm $2.9 \pm 0.2$ 0.85 + 0.25 1.50 - 0.15 $0.05 \pm 0.05$ GATE 1 2. GATE 2 3. DRAIN 4. SOURCE **JEDEC EIAJ TOSHIBA** 2-3J1A

## Weight: 0.013g

### ELECTRICAL CHARACTERISTICS (Ta = 25°C)

ELECTRICAL CITATORICATION (14 - 23 C)								
CHARACTERISTIC	SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT		
Gate 1 Leakage Current	I <sub>G1SS</sub>	$V_{DS} = 0V, V_{G1S} = \pm 6V, V_{G2S} = 0V$	_	_	±50	nA		
Gate 2 Leakage Current	$I_{G2SS}$	$V_{DS} = 0V, V_{G1S} = 0V, V_{G2S} = \pm 6V$		_	±50	nA		
Drain-Source Voltage	V (BR) DSX	$egin{array}{l} V_{G1S}\!=\!-4V,\ V_{G2S}\!=\!-4V \ I_{D}\!=\!100\mu\mathrm{A} \end{array}$	15	_	_	V		
Drain Current	I <sub>DSS</sub> (Note)	$V_{DS}=6V, V_{G1S}=0V, V_{G2S}=3V$	0	_	6	mA		
Gate 1-Source Cut-off Voltage	VG1S (OFF)	$V_{DS} = 6V, V_{G2S} = 3V, I_{D} = 100 \mu A$	-1.5	_	1.0	V		
Gate 2-Source Cut-off Voltage	$v_{G2S(OFF)}$	$V_{DS} = 6V, V_{G1S} = 3V, I_{D} = 100 \mu A$	-1.0	_	1.0	V		
Forward Transfer Admittance	Y <sub>fs</sub>	$V_{DS}$ =6V, $V_{G2S}$ =3V, $I_{D}$ =10mA f=1kHz	_	17	_	mS		
Input Capacitance	$\mathrm{c_{iss}}$	$V_{DS} = 6V, V_{G2S} = 3V, I_{D} = 10mA$	_	2.0	—	pF		
Reverse Transfer Capacitance	$\mathrm{C}_{\mathrm{rss}}$	f=1MHz		_	0.03	pF		
Power Gain	$G_{ m ps}$	$V_{DS} = 6V, V_{G2S} = 3V, I_{D} = 10mA$	_	16	_	dB		
Noise Figure	NF	f=800MHz (Fig.1)	_	3.2	_	dB		

Note: IDSS Classification O:0~2mA, Y:1~6mA

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TOSHIBA Semiconductor Reliability Handbook.

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## Marking

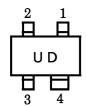
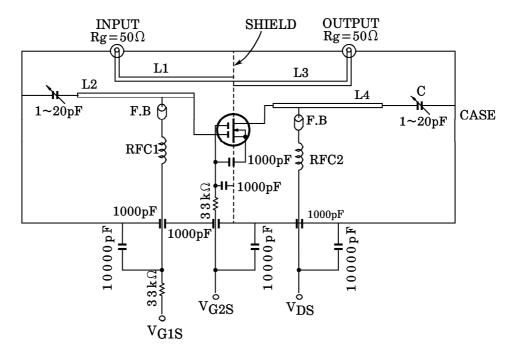


Fig. 1 800MHz Gps, NF TEST CIRCUIT



L1~L4 :  $\phi$ 0.8mm SILVER PLATED COPPER WIRE

C : AIR TRIMMER TTA25A200A (MURATA MFG, Co., Ltd.)

RFC 1 :  $\phi$ 0.35mm COPPER WIRE 3mm ID, 7T RFC 2 :  $\phi$ 0.35mm COPPER WIRE 3mm ID, 10T

